

## Silicon Carbide Diode Rev.02 - 29 January 2024

**Product data sheet** 

alogen-Free

Lead-Free

## **1. General description**

Dual Silicon Carbide Schottky diode in a TO247 plastic package, designed for high frequency switched-mode power supplies.



- Highly stable switching performance
- High forward surge capability I<sub>FSM</sub>
- Extremely fast reverse recovery time
- Superior in efficiency to Silicon Diode alternatives
- Reduced losses in associated MOSFET
- Reduced EMI
- Reduced cooling requirements
- RoHS compliant
- High junction operating temperature capability (T<sub>i(max)</sub> = 175 °C)

## 3. Applications

- Power factor correction
- Telecom / Server SMPS
- UPS
- PV inverter
- PC Silverbox
- LED / OLED TV
- Motor Drives

## 4. Quick reference data

able 1. Q	uick reference data						
Symbol	Parameter	Conditions	Notes		Values		Unit
Absolute	maximum rating						
$V_{\text{RRM}}$	repetitive peak reverse voltage				1200		V
I <sub>O(AV)</sub>	limiting average forward current	δ = 0.5 ; square-wave pulse; T <sub>mb</sub> ≤ 148 °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3		10			А
Tj	junction temperature			-55 to 175			°C
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
V <sub>F</sub>	forward voltage	$I_F = 5 \text{ A}; T_j = 25 \text{ °C}; \text{ per diode}; Fig. 5$		-	1.42	1.60	V
		$I_F = 5 \text{ A}; T_j = 150 \text{ °C}; \text{ per diode}; Fig. 5$		-	1.90	2.30	V
	I <sub>F</sub> = 5 A; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 5</u>			-	2.00	2.50	V
Dynamic	characteristics					,	
Q <sub>r</sub>	recovered charge	$I_F = 5 \text{ A}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s}; \text{ V}_R = 400 \text{ V};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$		-	11	-	nC

# **5. Pinning information**

Table 2. F	Pinning infor	mation		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode		
2	К	cathode		
3	A2	anode		к К
mb	mb	mounting base; connected to cathode		sym125

# 6. Ordering information

Table 3. Ordering information											
Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date					
WNSC2D101200CW	TO247	WNSC2D101200CW6Q	Tube	30	SOT429 (L)	25-Mar-2013					
					TO247P (P)	31-Mar-2023					

# 7. Marking

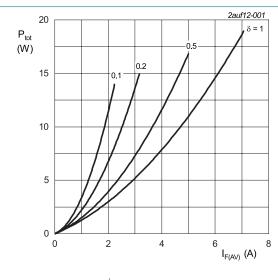
Table 4. Marking codes		
Type number	Marking codes	
WNSC2D101200CW	WNSC2D 101200CW	

# 8. Limiting values

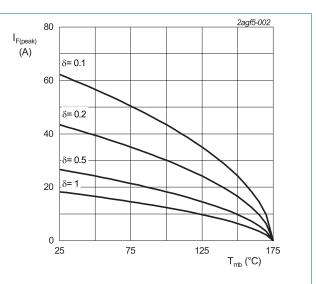
### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
$V_{\text{RRM}}$	repetitive peak reverse voltage			1200	V
$V_{\text{RWM}}$	crest working reverse voltage			1200	V
$V_{R}$	reverse voltage	DC		1200	V
I <sub>O(AV)</sub>	limiting average forward current	δ = 0.5; square-wave pulse; T <sub>mb</sub> ≤ 148 °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3		10	A
I <sub>FRM</sub>	repetitive peak forward current	$\delta$ = 0.5; t <sub>p</sub> = 25 µs; T <sub>mb</sub> ≤ 149 °C; square-wave pulse; per diode		10	A
I <sub>FSM</sub>	non-repetitive peak forward current	$t_p$ = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode		45	A
		$t_p$ = 10 µs; $T_{j(init)}$ = 25 °C; square-wave pulse; per diode		450	A
l <sup>2</sup> t	l <sup>2</sup> t for fusing	sine-wave pulse; $T_{j(init)}$ = 25 °C; $t_p$ = 10 ms		10.13	A <sup>2</sup> s
T <sub>stg</sub>	storage temperature			-55 to 175	°C
Tj	junction temperature			-55 to 175	°C



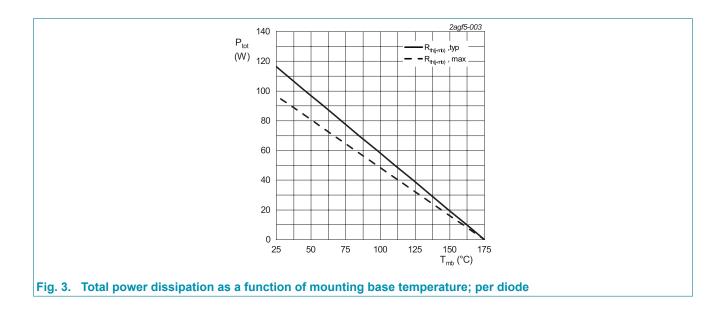
 $\begin{array}{l} {\sf I}_{\sf F(AV)} = {\sf I}_{\sf F(RMS)} \times \sqrt{\delta} \\ {\sf V}_{\sf o} = 1.027 \; V; \; {\sf R}_{\sf s} = 0.2336 \; \Omega \end{array}$ Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values; per diode





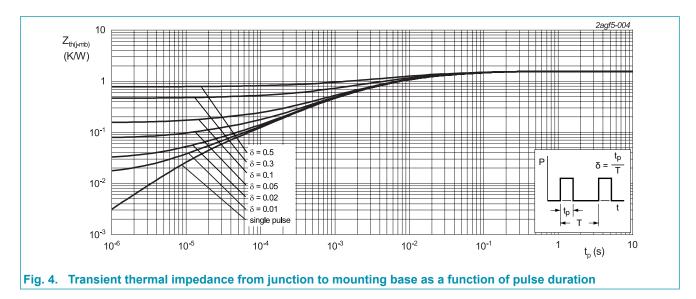
## **WeEn Semiconductors**

## WNSC2D101200CW Silicon Carbide Diode



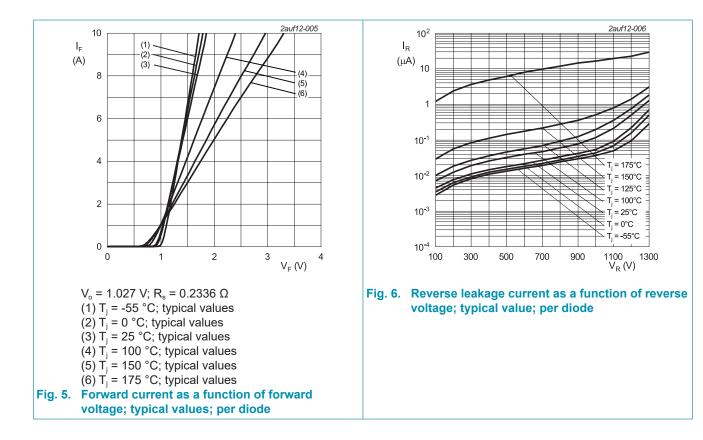
# 9. Thermal characteristics

Table 6. Th	ermal characteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub> thermal resistance from junction to mounting base		per diode; <u>Fig. 4</u>		-	1.29	1.55	K/W
	-	both diodes conducting		-	0.65	0.8	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient free air	in free air		-	60	-	K/W



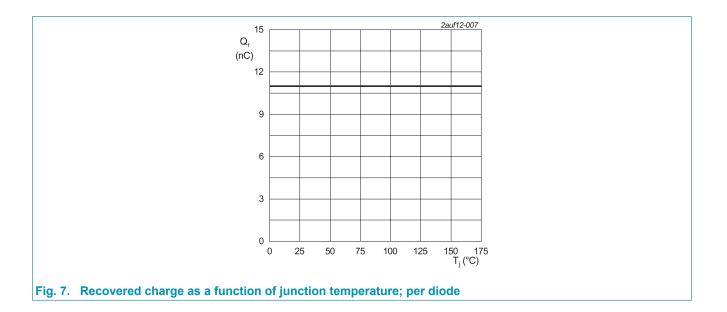
## **10. Characteristics**

Table 7. Cl	naracteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
V <sub>F</sub>	forward current	I <sub>F</sub> = 5 A; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 5</u>		-	1.42	1.60	V
		I <sub>F</sub> = 5 A; T <sub>j</sub> = 150 °C; per diode; <u>Fig. 5</u>		-	1.90	2.30	V
		I <sub>F</sub> = 5 A; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 5</u>		-	2.00	2.50	V
I <sub>R</sub> reverse current		V <sub>R</sub> = 1200 V; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 6</u>		-	0.5	25	μA
		$V_{R}$ = 1200 V; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 6</u>		-	25	300	μA
Dynamic	characteristics						
Q <sub>r</sub>	recovered charge	I <sub>F</sub> = 5 A; V <sub>R</sub> = 400 V; dI <sub>F</sub> /dt = 500 A/μs; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 7</u>		-	11	-	nC
C <sub>d</sub>	diode capacitance	f = 1 MHz; $V_R$ = 1 V; $T_j$ = 25 °C; per diode		-	260	-	pF
		f = 1 MHz; $V_R$ = 400 V; $T_j$ = 25 °C; per diode		-	22	-	pF
		f = 1 MHz; $V_R$ = 800 V; $T_j$ = 25 °C; per diode		-	16	-	pF
E <sub>as</sub>	non-repetitive avalanche energy	$I_R = 2.9 \text{ A}; \text{ L} = 10 \text{ mH}; \text{ T}_{j(init)} = 25 \text{ °C};$ per diode		42	-	-	mJ



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Silicon Carbide Diode



### Silicon Carbide Diode

# 11. Package outline

lastic single-end	led th	rough	1-hole	pack	age;	heats	ink m	ounte	ed; 1	mount	ting h	ole; 3	-lead	то-2	47					SOT42
					► b1	[2- ] 3		-												
Dimensions (mm a	re the c	origina	l dimer	nsions)			0		SCa	ale		ا 20 لــــا								
Unit <sup>(1)</sup> A	A <sub>1</sub>	b	b <sub>1</sub>		с	D	D <sub>1</sub>	D <sub>2</sub>	E	E1	Fo	Fa	e <sup>(1)</sup>	L	L <sub>1</sub>	Pa		Q		ø
max 5.20				b <sub>2</sub>												P <sub>2</sub>	p 3 70		q 6 18	7.30
mm nom													5.45							
min 4.70 Note	1.90	1.00	1.80	2.80	0.50	20.3	17.28	0.80	15.45	13.82	4.80	1.40		20.40	4.25	3.40	3.50	2.20	J./8	7.10
1. Basic spacing be	etween	center	rs.																so	t429_po
Outline							eferenc								Europ	bean		ls	sue da	te
version		IEC	2		JED	EC		JE	EITA						proje	clion		-		
																		-	4-09-1	

### Silicon Carbide Diode

# 12. Legal information

### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions".
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## **13. Contents**

1.	General description	.1
2.	Features and benefits	.1
3.	Applications	.1
4.	Quick reference data	.1
5.	Pinning information	2
6.	Ordering information	.2
7.	Marking	2
8.	Limiting values	3
9.	Thermal characteristics	5
10.	Characteristics	6
11.	Package outline	8
12	Legal information	9
13.	Contents	11

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